

In The Claims

✓ 2. (Currently amended) A measurement system comprising:
a first log amp;
a second log amp; and
a differencing circuit coupled to the first and second log amps, wherein the differencing circuit is arranged to continuously process outputs from the first and second log amps;

wherein the first and second log amps are progressive compression log amps.

✓ 3. (Previously amended) A measurement system according to claim 2 wherein:
the first log amp has a first logarithmic output coupled to a first input to the differencing circuit; and
the second log amp has a second logarithmic output coupled to a second input to the differencing circuit.

(15) ✓ 4. (Currently amended) A measurement system comprising:
a first log amp;
a second log amp; and
a differencing circuit coupled to the first and second log amps, wherein the differencing circuit ~~comprises~~ consists essentially of a summing node.

✓ 5. (Currently amended) A measurement system according to claim 2 ~~further comprising an output interface circuit coupled to the differencing circuit.~~ wherein the differencing circuit comprises an output interface circuit.

6. (Previously amended) A measurement system comprising:
a first log amp;
a second log amp;
a differencing circuit coupled to the first and second log amps; and
a phase detector core coupled to the first and second log amps.

7. (Original) A measurement system according to claim 6 wherein:
the first log amp has a first limiting output coupled to a first input of the phase detector core; and
the second log amp has a second limiting output coupled to a second input of the phase detector core.
8. (Original) A measurement system according to claim 7 wherein the detector core comprises a multiplier.
9. (Original) A measurement system according to claim 6 further comprising an output interface circuit coupled to the phase detector core.
- ✓ 10. (Currently amended) A measurement system comprising:
a first log amp; and
a second log amp;
wherein the first and second log amps are progressive compression log amps co-integrated on a substrate. *not in spec*
11. (Currently amended) A measurement system ~~according to claim 10~~ comprising:
a first log amp; and
a second log amp;
wherein the first and second log amps are co-integrated on a substrate; and
wherein the first and second log amps are arranged symmetrically about a center line.
- ✓ 12. (Original) A measurement system circuit according to claim 10 wherein the substrate is mounted in a package.
13. (Currently amended) A measurement system ~~according to claim 12~~ further comprising:
a first log amp;
a second log amp;
a first parasitic network coupled to the first log amp; and
a second parasitic network coupled to the second log amp;

wherein the first and second log amps are co-integrated on a substrate;

wherein the substrate is mounted in a package; and

wherein the first and second parasitic networks have similar frequency responses.

- allow*
14. (Currently amended) A measurement system comprising:
- a first log amp;
 - a second log amp;
 - a differencing circuit having first and second inputs coupled to the first and second log amps, respectively; and
 - a third log amp coupled to a third input of the differencing circuit.

- allow*
15. (Currently amended) A measurement system comprising:
- a first log amp;
 - a second log amp;
 - a differencing circuit having first and second inputs coupled to the first and second log amps, respectively; and
 - one or more additional log amps coupled to one or more additional inputs of the differencing circuit.

- OK*
16. (Original) A measurement system comprising:
- a first log amp having a first limiting output;
 - a second log amp having a second limiting output; and
 - a phase detector core coupled to the first and second log amps to receive the first and second limiting outputs.

- allow*
17. (Original) A measurement system according to claim 16 wherein the phase detector core comprises a multiplier.

18. (Original) A measurement system according to claim 16 wherein the first and second log amps are co-integrated on a substrate.

- ✓
19. (Currently amended) An integrated circuit comprising two or more progressive compression log amps.

20. (Currently amended) An integrated circuit according to claim 19 further comprising a differencing circuit coupled to the two or more progressive compression log amps. *not in spec*

21. (Currently amended) An integrated circuit ~~according to claim 19~~ further comprising comprising:

OK allow
two or more log amps
a differencing circuit coupled to the two or more log amps; and
a phase detector core coupled to the two or more log amps.

CS
✓ 22. (Currently amended) A method comprising:
logarithmically amplifying a first input signal, thereby generating a first output signal;
logarithmically amplifying a second input signal, thereby generating a second output signal; and
differentially and continuously processing the first and second output signals;
wherein logarithmically amplifying comprises progressively compressing. *not in spec*

23. (Original) A method according to claim 22 wherein:
the first and second output signals are logarithmic output signals; and
differentially processing the first and second output signals comprises differencing the first and second output signals.

all done
24. (Previously amended) A method comprising:
logarithmically amplifying a first input signal, thereby generating a first output signal;
logarithmically amplifying a second input signal, thereby generating a second output signal; and
differentially processing the first and second output signals
wherein:
the first and second output signals are limiting output signals; and
differentially processing the first and second output signals comprises multiplying the first and second output signals.

25. (Previously amended) A method comprising:
logarithmically amplifying a first input signal, thereby generating a first output signal;
logarithmically amplifying a second input signal, thereby generating a second output
signal;

allow
differentially processing the first and second output signals;
(utilizing a signal to be examined as the first input signal; and
utilizing a reference signal as the second input signal.)

allow
26. (Original) A method according to claim 25 wherein the reference signal has
the same waveform as the signal to be examined.

allow
27. (Previously amended) A method comprising:
logarithmically amplifying a first input signal, thereby generating a first output signal;
logarithmically amplifying a second input signal, thereby generating a second output
signal;

CS
cont.
allow
differentially processing the first and second output signals;
utilizing a modulated signal for the first input signal; and
utilizing a modulation signal for the second input signal.

allow
28. (Previously added) A measurement system according to claim 2 further
comprising a power amplifier having an input coupled to an input of the first log amp and an
output coupled to an input of the second log amp.

allow
29. (Currently amended) A measurement system according to claim 4 wherein the
log amps have current-mode outputs.